


<b>Search Notes</b>  	<b>Application/Control No.</b>  10769701	<b>Applicant(s)/Patent Under Reexamination</b>  OKAMURA ET AL.
	<b>Examiner</b>  HABTE MERED	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
370	230, 229, 230.1, 232, 233, 235, 236, 236.1, 236.2, 237, 238, 477, 395.2, 395.21	12-28-08	HM
709	235, 238, 239, 240, 242, 244, 228, 229	12-28-08	HH

SEARCH NOTES		
Search Notes	Date	Examiner
Searched East DB: USPAT, USPGPUB, JPO, EPO	12-28-08	HM
IEEE	12-28-08	HM
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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